Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination
•	10/643,276	LEE ET AL.
	Examiner	Art Unit
	Don P. Le	2819

	SEARCHED		
Class	Subclass	Date	Examiner
326	37-41	2/1/2005	DL
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
326	37, 38	2/2/2005	DL	
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	DATE	EXMR
east updated	2/1/2005	DL